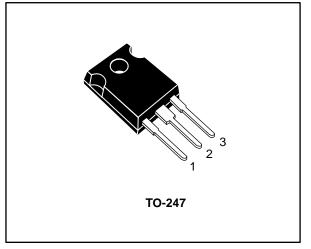
# STW35N60DM2

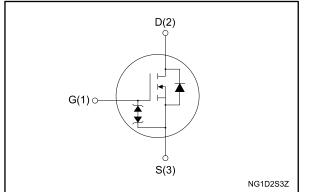


## N-channel 600 V, 0.094 Ω typ., 28 A MDmesh<sup>™</sup> DM2 Power MOSFET in a TO-247 package

Datasheet - production data



#### Figure 1: Internal schematic diagram



### **Features**

Order code	V <sub>DS</sub>	R <sub>DS(on)</sub> max.	ID	Ртот
STW35N60DM2	600 V	0.110 Ω	28 A	210 W

- Fast-recovery body diode
- Extremely low gate charge and input capacitance
- Low on-resistance
- 100% avalanche tested
- Extremely high dv/dt ruggedness
- Zener-protected

### **Applications**

• Switching applications

### Description

This high voltage N-channel Power MOSFET is part of the MDmesh<sup>TM</sup> DM2 fast recovery diode series. It offers very low recovery charge ( $Q_{rr}$ ) and time ( $t_{rr}$ ) combined with low  $R_{DS(on)}$ , rendering it suitable for the most demanding high efficiency converters and ideal for bridge topologies and ZVS phase-shift converters.

#### Table 1: Device summary

Order code	Marking	Package	Packing
STW35N60DM2	35N60DM2	TO-247	Tube

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This is information on a product in full production.

### Contents

### Contents

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# 1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
V <sub>GS</sub>	Gate-source voltage	±25	V
	Drain current (continuous) at T <sub>case</sub> = 25 °C	28	٨
Ι <sub>D</sub>	Drain current (continuous) at T <sub>case</sub> = 100 °C	17	A
I <sub>DM</sub> <sup>(1)</sup>	Drain current (pulsed)	112	А
P <sub>TOT</sub>	Total dissipation at T <sub>case</sub> = 25 °C	210	W
dv/dt <sup>(2)</sup>	Peak diode recovery voltage slope	50	V/ns
dv/dt <sup>(3)</sup>	MOSFET dv/dt ruggedness	50	v/ns
T <sub>stg</sub>	Storage temperature	-55 to 150	°C
Tj	Operating junction temperature	-55 10 150	C

#### Notes:

 $^{\left( 1\right) }$  Pulse width is limited by safe operating area.

 $^{(2)}$  I\_{SD}  $\leq 28$  A, di/dt=900 A/µs; V\_{DS} peak < V\_{(BR)DSS}, V\_{DD} = 400 V

<sup>(3)</sup>  $V_{DS} \le 480 \text{ V}.$ 

#### Table 3: Thermal data

Symbol	Parameter	Value	Unit
R <sub>thj-case</sub>	Thermal resistance junction-case	0.6	9 <b>0</b> A A/
R <sub>thj-amb</sub>	Thermal resistance junction-amb	50	°C/W

#### Table 4: Avalanche characteristics

Symbol	Parameter	Value	Unit
I <sub>AR</sub>	Avalanche current, repetitive or not repetitive	6	А
E <sub>AS</sub> <sup>(1)</sup>	Single pulse avalanche energy	650	mJ

### Notes:

 $^{(1)}$  starting  $T_{j}$  = 25 °C,  $I_{D}$  =  $I_{AR},\,V_{DD}$  = 50 V.



## 2 Electrical characteristics

 $(T_{case} = 25 \text{ °C unless otherwise specified})$ 

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage	$V_{GS}$ = 0 V, $I_D$ = 1 mA	600			V
	Zoro goto voltago droin	$V_{GS} = 0 V, V_{DS} = 600 V$			10	
I <sub>DSS</sub>	Zero gate voltage drain current	$V_{GS} = 0 V$ , $V_{DS} = 600 V$ , $T_{case} = 125 $ °C			100	μA
I <sub>GSS</sub>	Gate-body leakage current	$V_{DS}$ = 0 V, $V_{GS}$ = ±25 V			±5	μA
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{\text{DS}} = V_{\text{GS}}, \ I_{\text{D}} = 250 \ \mu\text{A}$	3	4	5	V
R <sub>DS(on)</sub>	Static drain-source on- resistance	$V_{GS} = 10 \text{ V}, I_D = 14 \text{ A}$		0.094	0.11	Ω

Table 6: Dynamic							
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit	
C <sub>iss</sub>	Input capacitance		-	2400	-		
C <sub>oss</sub>	Output capacitance	V <sub>DS</sub> = 100 V, f = 1 MHz, V <sub>GS</sub> = 0 V	-	110	-	pF	
C <sub>rss</sub>	Reverse transfer capacitance		-	2.8	-		
C <sub>oss</sub>	Equivalent output capacitance	$V_{DS} = 0$ to 480 V, $V_{GS} = 0$ V	-	190	-	pF	
R <sub>G</sub>	Intrinsic gate resistance	f = 1 MHz, I <sub>D</sub> = 0 A	-	4.3	-	Ω	
Qg	Total gate charge		-	54	-		
Q <sub>gs</sub>	Gate-source charge	$V_{DD}$ = 480 V, $I_D$ = 28 A, $V_{GS}$ = 10 V (see Figure 15: "Test circuit for gate charge behavior")	-	14.6	-	nC	
Q <sub>gd</sub>	Gate-drain charge		-	24.2	-		

#### Notes:

 $^{(1)}$   $C_{oss\ eq.}$  is defined as a constant equivalent capacitance giving the same charging time as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}.$ 

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit	
t <sub>d(on)</sub>	Turn-on delay time	$V_{DD}$ = 300 V, $I_D$ = 14 A R <sub>G</sub> = 4.7 $\Omega$ , V <sub>GS</sub> = 10 V (see <i>Figure 14: "Test circuit for</i> <i>resistive load switching times"</i> and <i>Figure 19:</i> <i>"Switching time waveform"</i> )	-	21.2	-		
tr	Rise time		-	17	-		
$t_{d(off)}$	Turn-off delay time		-	68	-	ns	
t <sub>f</sub>	Fall time		-	10.7	-		

**Table 7: Switching times** 

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#### STW35N60DM2

#### Electrical characteristics

	Table 8: Source-drain diode							
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit		
I <sub>SD</sub>	Source-drain current		-		28	А		
Isdm <sup>(1)</sup>	Source-drain current (pulsed)		-		112	A		
V <sub>SD</sub> <sup>(2)</sup>	Forward on voltage	$V_{GS} = 0 V, I_{SD} = 28 A$	-		1.6	V		
t <sub>rr</sub>	Reverse recovery time	$I_{SD} = 28 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}, V_{DD} = 60 \text{ V}$ (see Figure 16: "Test circuit for inductive load switching and diode recovery times")	-	120		ns		
Q <sub>rr</sub>	Reverse recovery charge		-	572		nC		
I <sub>RRM</sub>	Reverse recovery current		-	10.2		A		
t <sub>rr</sub>	Reverse recovery time		-	215		ns		
Q <sub>rr</sub>	Reverse recovery charge	$I_{SD}$ = 28 A, di/dt = 100 A/µs, V <sub>DD</sub> = 60 V, T <sub>j</sub> = 150 °C (see Figure 16: "Test circuit for inductive load switching and diode	-	1.89		μC		
I <sub>RRM</sub>	Reverse recovery current	recovery times")	-	17.7		А		

#### Notes:

<sup>(1)</sup> Pulse width is limited by safe operating area.

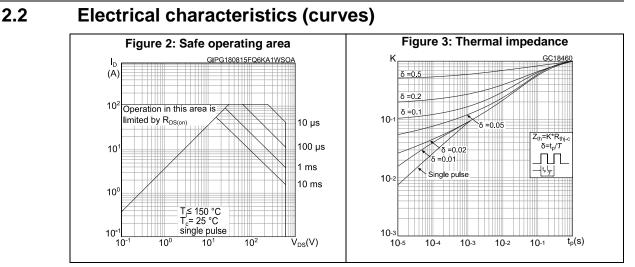
 $^{(2)}$  Pulse test: pulse duration = 300  $\mu s,$  duty cycle 1.5%.

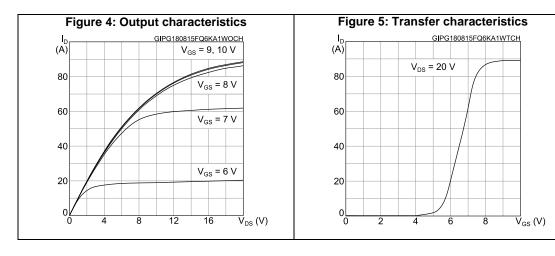
#### Table 9: Gate-source Zener diode

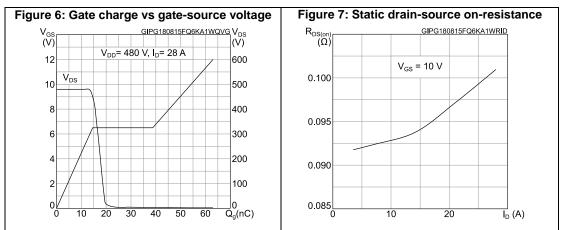
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)GSO</sub>	Gate-source breakdown voltage	$I_{GS} = \pm 250 \ \mu A, I_D = 0 \ A$	±30	-	-	V

The built-in back-to-back Zener diodes are specifically designed to enhance the ESD performance of the device. The Zener voltage facilitates efficient and cost-effective device integrity protection, thus eliminating the need for additional external componentry.





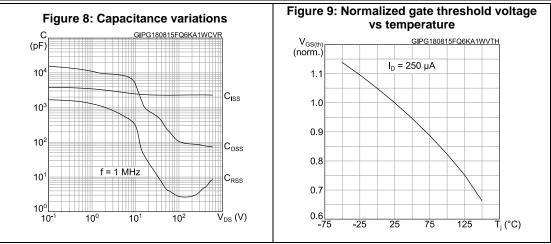


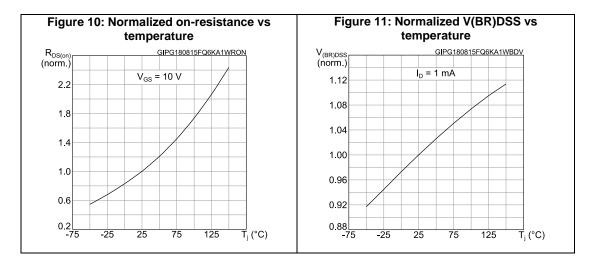


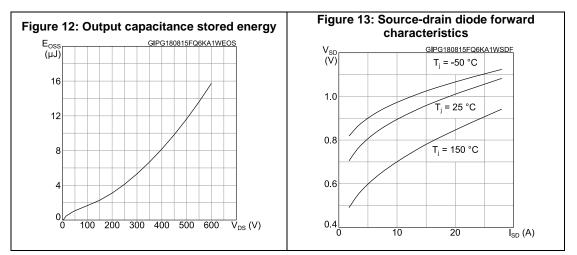


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#### **Electrical characteristics**

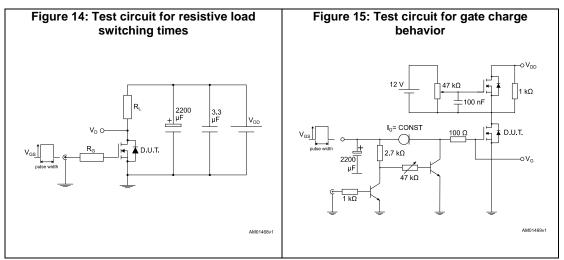


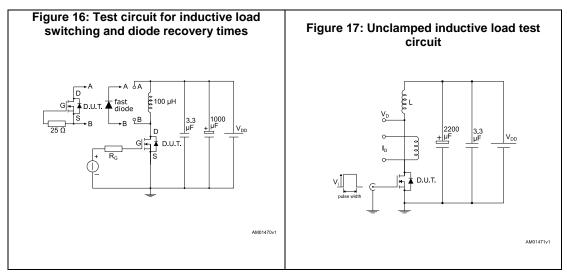


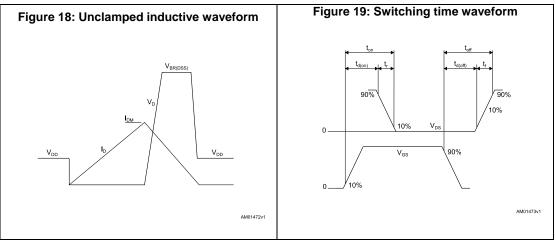


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### 3 Test circuits







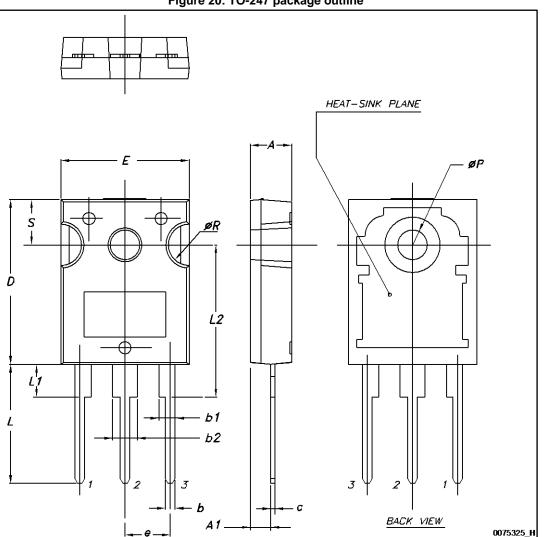
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#### **Package information** 4

In order to meet environmental requirements, ST offers these devices in different grades of  $ECOPACK^{\$}$  packages, depending on their level of environmental compliance.  $ECOPACK^{\$}$ specifications, grade definitions and product status are available at: www.st.com. ECOPACK<sup>®</sup> is an ST trademark.

#### 4.1 **TO-247** package information







### Package information

### STW35N60DM2

nformation			51W35N60DM2	
Table 10: TO-247 package mechanical data				
Dim.	mm.			
	Min.	Тур.	Max.	
А	4.85		5.15	
A1	2.20		2.60	
b	1.0		1.40	
b1	2.0		2.40	
b2	3.0		3.40	
С	0.40		0.80	
D	19.85		20.15	
E	15.45		15.75	
е	5.30	5.45	5.60	
L	14.20		14.80	
L1	3.70		4.30	
L2		18.50		
ØP	3.55		3.65	
ØR	4.50		5.50	
S	5.30	5.50	5.70	

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## 5 Revision history

Table 11: Document revision history

Date	Revision	Changes
02-Sep-2015	1	Initial version



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